Search Notes



Application/Control N	0
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08471890

Applicant(s)/Patent Under Reexamination

HUFFMAN ET AL.

Examiner

DAH-WEI YUAN

Art Unit

1717

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Reviewed parent case 07/580,246	8/2011	DWY
423/445B; 977/735, 844, 845- limited by text- See EAST Search History	8/2011	DWY

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
423	445B	8/30/2011	DWY
977	735	8/30/2011	DWY
977	844	8/30/2011	DWY
977	845	8/30/2011	DWY

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